


<b>Search Notes</b> 	<b>Application/Control No.</b> 09196680	<b>Applicant(s)/Patent Under Reexamination</b> MEYER ET AL.
	<b>Examiner</b> CHRISTOPHER KIM	<b>Art Unit</b> 3752

SEARCHED			
Class	Subclass	Date	Examiner
169	37,38,39,40,41,42,56,57,70		
239	498,500,504,518,524	12/20/2011	CK

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
EAST		12/20/2011	CK

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